

**Search Notes**

Application/Control No.

10/618,807

Examiner

M. Lee

Applicant(s)/Patent under  
Reexamination

UEKI, KEIJIRO

Art Unit

2614

**SEARCHED**

Class	Subclass	Date	Examiner
348	643	3/13/2006	ML
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	644		
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	708		
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/13/2006	ML

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference search history printout		3/13/2006	ML